

Notice of References Cited	Application/Control No. 10/710,366	Applicant(s)/Patent Under Reexamination CHEN, HENG-CHIEN	
	Examiner Lina Yang	Art Unit 2665	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0172464	09-2004	Nag, Siddhartha	709/223
	B	US-2003/0031134	02-2003	Chiu, Tienyu	370/252
	C	US-2004/0128531	07-2004	Rotholtz, Ben Aaron	713/200
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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	P					
	Q					
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NON-PATENT DOCUMENTS

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